EVVOSEMI®
THINK CHANGE DO

ESD TVS MOS LDO Diode Sensor DC-DC

Product Specification

Domestic Part Number	IRF3710S
Overseas Part Number	IRF3710S
Equivalent Part Number	IRF3710S

100V N-SGT Enhancement Mode MOSFET

General Description

IRF3710S use advanced SGT MOSFET technology to provide low RDS(ON), low gate charge, fast switching and excellent avalanche characteristics.

This device is specially designed to get better ruggedness and suitable to use in

Features

Low RDS(on) & FOM

Extremely low switching loss

Excellent stability and uniformity or Invertors

Applications

Consumer electronic power supply

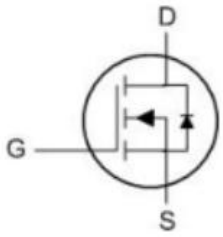
Motor control

Synchronous-rectification

Isolated DC

Synchronous-rectification applications

TO-263-2L Pin Configuration



Absolute Maximum Ratings at T_j=25℃ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain source voltage	V_{DS}	100	V
Gate source voltage	V_{GS}	±20	V
Continuous drain current[1], T_C=25 ℃	I_D	80	A
Pulsed drain current[2], T_C=25 ℃	$I_{D,pulse}$	180	A
Power dissipation[3], T_C=25 ℃	P_D	125	W
Single pulsed avalanche energy[5]	E_{AS}	100	mJ
Operation and storage temperature	T_{stg}, T_j	-55 to 150	℃
Thermal resistance, junction-case	$R_{\theta JC}$	1	℃/W
Thermal resistance, junction-ambient[4]	$R_{\theta JA}$	62	℃/W

100V N-SGT Enhancement Mode MOSFET

Electrical Characteristics at T_j=25 ℃ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-source breakdown voltage	BVDSS	100			V	V_{GS}=0 V, I_D=250 μA
Gate threshold voltage	VGS(th)	1.0		2.5	V	V_{DS}=V_{GS}, I_D=250 μA
Drain-source on-state resistance	RDS(ON)		8	10	mΩ	V_{GS}=10 V, I_D=10 A
Drain-source on-state resistance	RDS(ON)		10	12	mΩ	V_{GS}=4.5 V, I_D=10 A
Gate-source leakage current	IGSS			100	nA	V_{GS}=20 V
				-100		V_{GS}=-20 V
Drain-source leakage current	IDSS			1	μA	V_{DS}=100 V, V_{GS}=0 V
Input capacitance	Ciss		2604		pF	V_{GS}=0 V, V_{DS}=50 V, f=1 MHz
Output capacitance	Coss		361.2		pF	
Reverse transfer capacitance	Crss		6.5		pF	
Turn-on delay time	td(on)		20.6		ns	V_{GS}=10 V, V_{DS}=50 V, R_G=2.2 Ω, I_D=25 A
Rise time	t_r		5		ns	
Turn-off delay time	td(off)		51.8		ns	
Fall time	t_f		9		ns	
Total gate charge	Q_g		49.9		nC	I_D=25 A, V_{DS}=50 V, V_{GS}=10 V
Gate-source charge	Q_{gs}		6.5		nC	
Gate-drain charge	Qgd		12.4		nC	
Gate plateau voltage	Vplateau		3.4		V	
Diode forward current	I_S			60		VGS<Vth
Pulsed source current	ISP			180	A	
Diode forward voltage	VSD			1.3	V	I_S=12 A, V_{GS}=0 V
Reverse recovery time	trr		60.4		ns	I_S=12 A, di/dt=100 A/μs
Reverse recovery charge	Q_{rr}		106.1		nC	
Peak reverse recovery current	Irrm		3		A	

Note

1) Calculated continuous current based on maximum allowable junction temperature.
2) Repetitive rating; pulse width limited by max. junction temperature.
3) Pd is based on max. junction temperature, using junction-case thermal resistance.
4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_a=25 ℃.
5) V_{DD}=50 V, R_G=25 Ω, L=0.3 mH, starting T_j=25 ℃.

Electrical Characteristics Diagrams

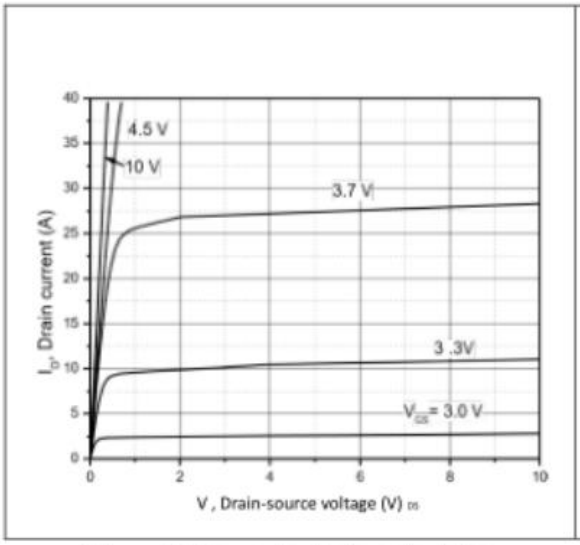


Figure 1, Typ. output characteristics

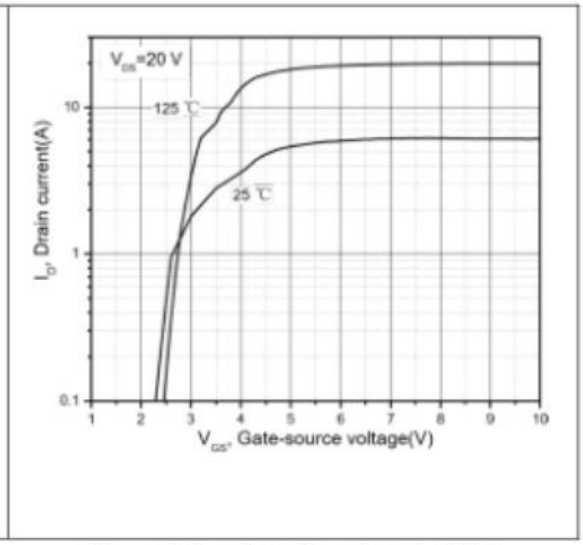


Figure 2, Typ. transfer characteristics

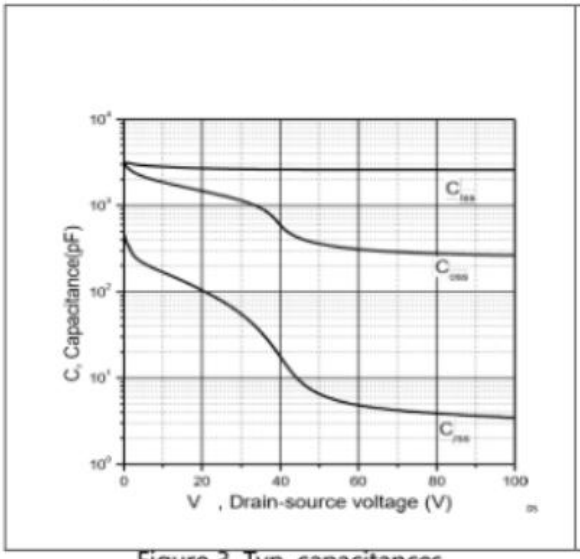


Figure 3, Typ. capacitances

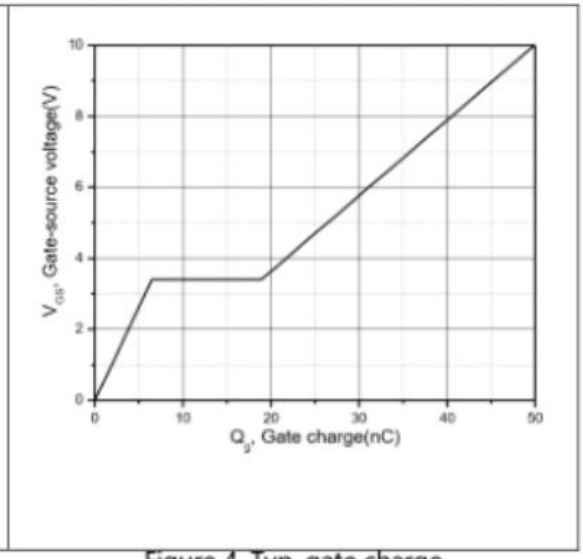


Figure 4, Typ. gate charge

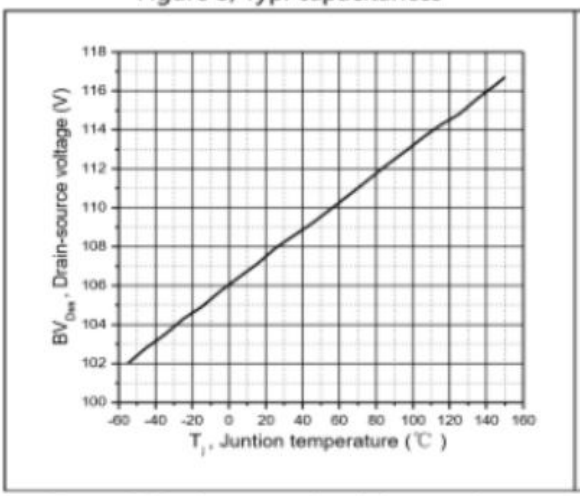


Figure 5, Drain-source breakdown voltage

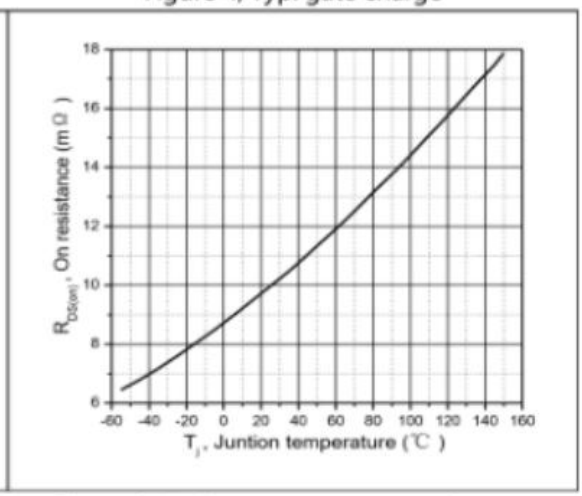


Figure 6, Drain-source on-state resistance

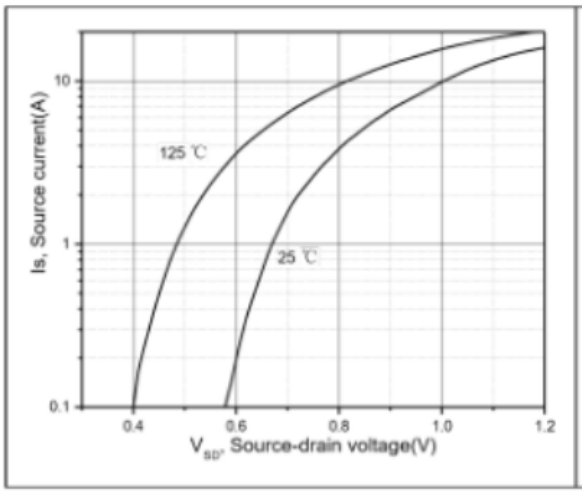


Figure 7, Forward characteristic of body diode

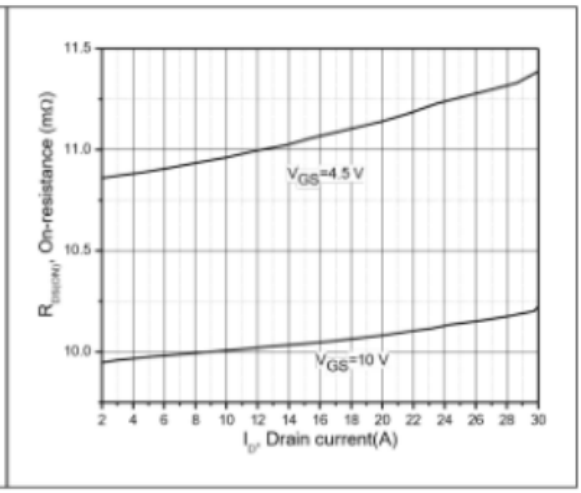


Figure 8, Drain-source on-state resistance

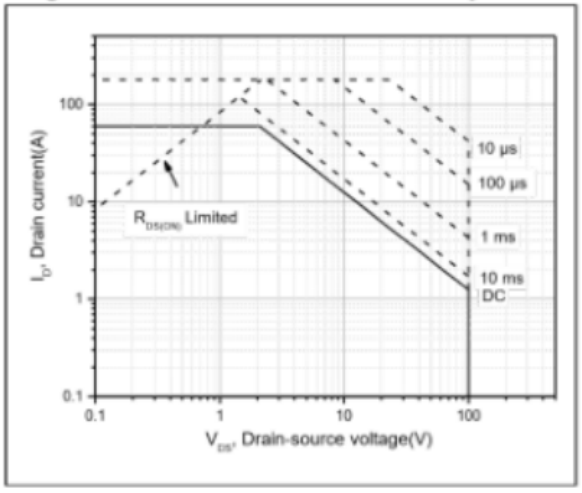


Figure 9, Safe operation area T_C=25 ℃

Test circuits and waveforms

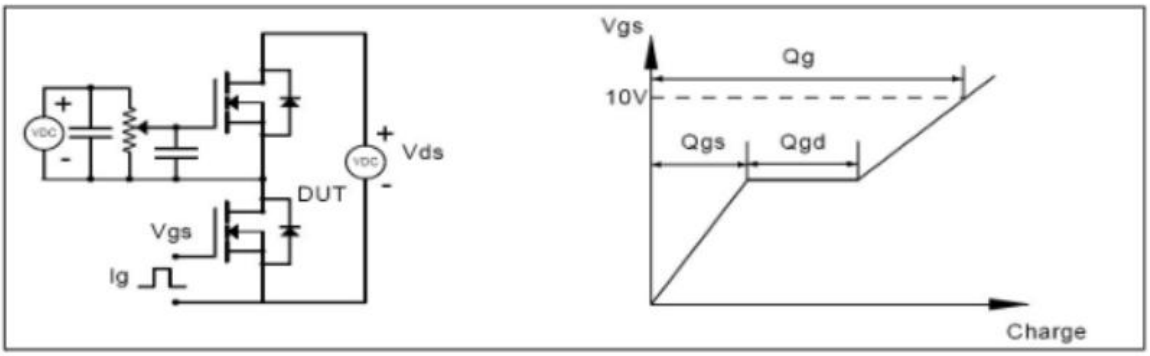


Figure 1, Gate charge test circuit & waveform

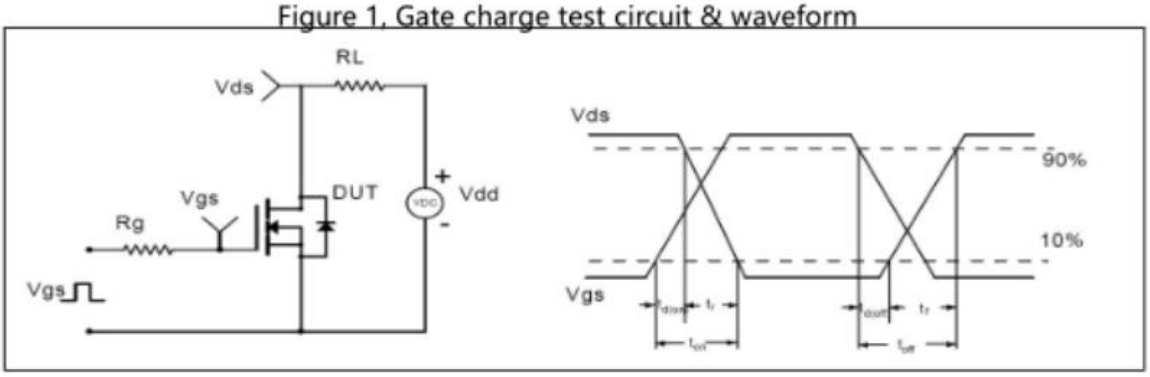


Figure 2, Switching time test circuit & waveforms

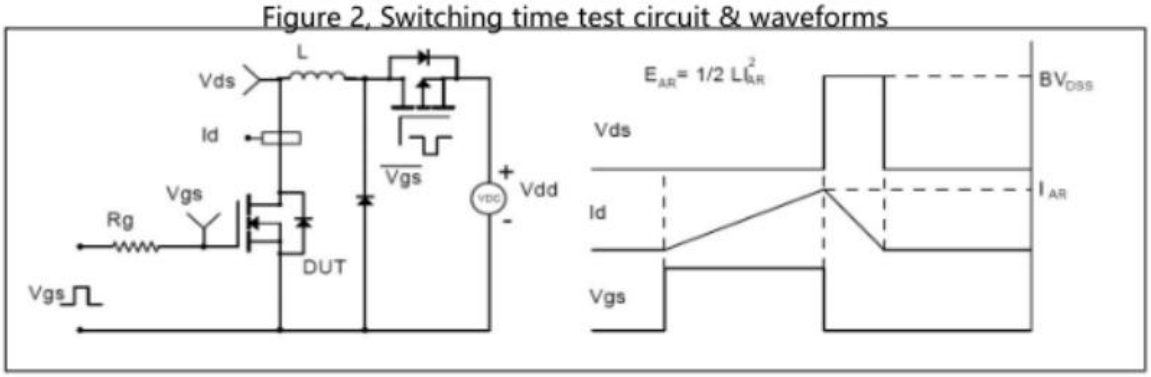


Figure 3, Unclamped inductive switching (UIS) test circuit & waveforms

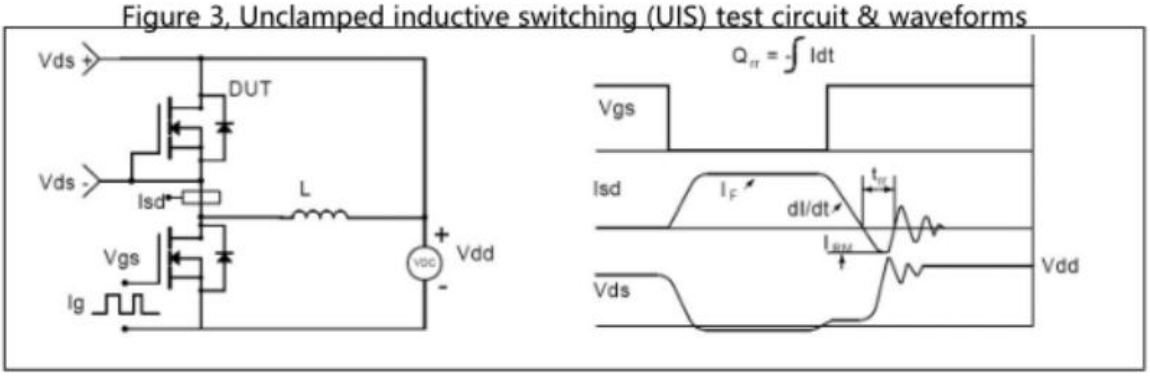
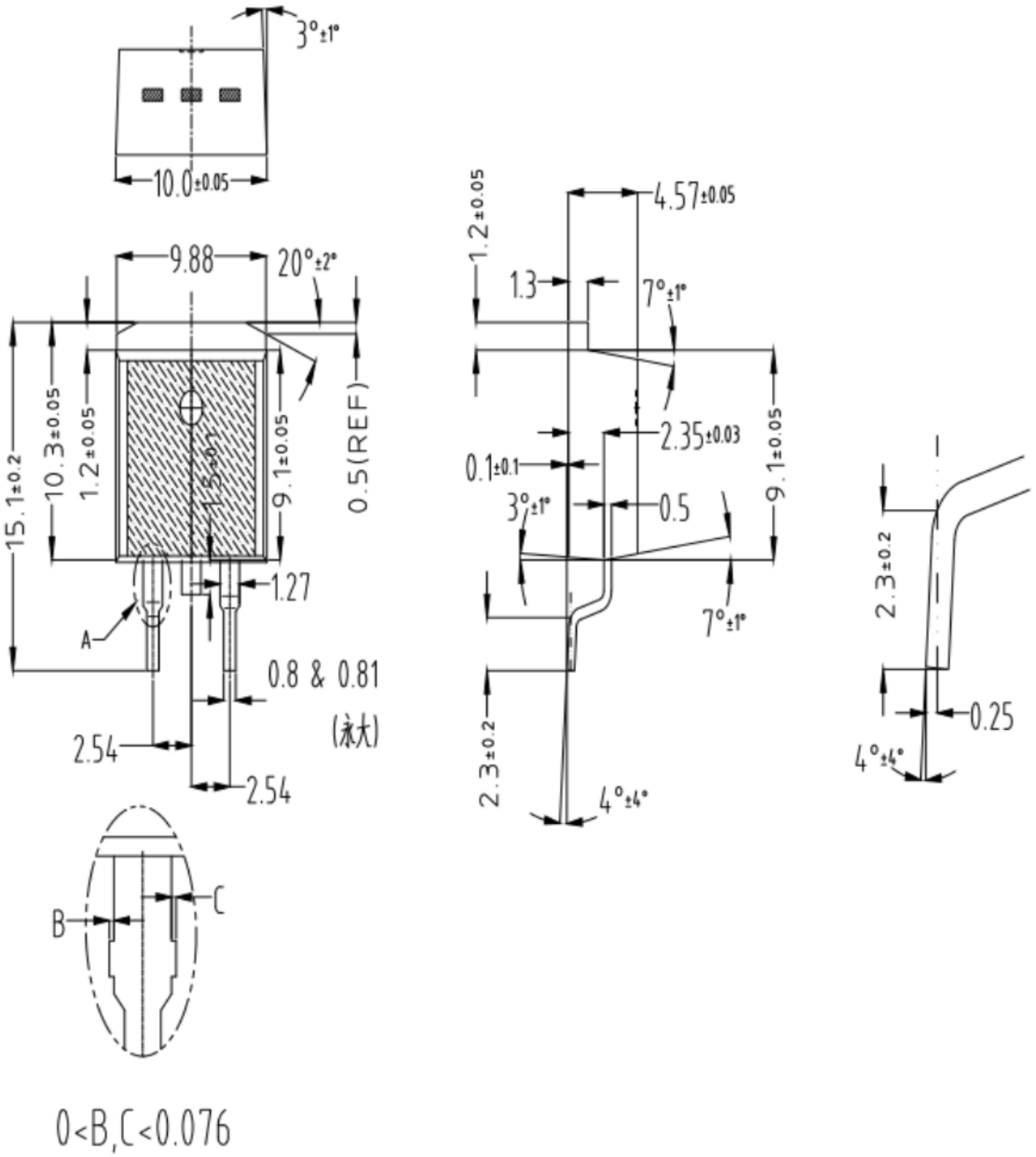


Figure 4, Diode reverse recovery test circuit & waveforms

TO-263 Package Outline Dimensions

Package Outline Dimensions (Units: mm)



Disclaimer

EVVOSEMI ("EVVO") reserves the right to make corrections, enhancements, improvements, and other changes to its products and services at any time, and to discontinue any product or service without notice.

EVVO warrants the performance of its hardware products to the specifications applicable at the time of sale in accordance with its standard warranty. Testing and other quality control techniques are used as deemed necessary by EVVO to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

Customers should obtain and confirm the latest product information and specifications before final design, purchase, or use. EVVO makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does EVVO assume any liability for application assistance or customer product design. EVVO does not warrant or accept any liability for products that are purchased or used for any unintended or unauthorized application.

EVVO products are not authorized for use as critical components in life support devices or systems without the express written approval of EVVOSEMI.

The EVVO logo and EVVOSEMI are trademarks of EVVOSEMI or its subsidiaries in relevant jurisdictions. EVVO reserves the right to make changes without further notice to any products herein.